Search Notes

Application/Control No.	Applicant(s)/Patent Under Reexamination
10562795	SATOH ET AL.
Examiner	Art Unit
HENOK G HEYI	2627

SEARCHED			
Class	Subclass	Date	Examiner

SEARCH NOTES		
Search Notes	Date	Examiner
Searched EAST. Some of the subclasses searched are 369/30.23 and 47.1 (text search only - please see search history printout).	02/29/2009	HH

INTERFERENCE SEARCH			
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